## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10015958	DE VORCHIK ET AL.
Examiner	Art Unit
Kiss, Eric B	2192

SEARCHED					
Class	Subclass	Date	Examine		
/Ia55	Subciass	Date	LAGII		

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted w/ P.Salce QAS-2100; 35 U.S.C. 101 Subject Matter Eligibility	11/29/2006	EBK

INTERFERENCE SEARCH					
Subclass	Date	Examine			
	Subclass	Subclass Date			